

Hearing Aid Compatibility (HAC) RF Emission Test Report

APPLICANT : Reliance Communications LLC

PRODUCT NAME : Orbic Fun Pro 5G

MODEL NAME : R678L5SLFP

BRAND NAME : Orbic

FCC ID : 2ABGH-R678L5SLFP

STANDARD(S) : FCC 47 CFR Part 20 (20.19)

ANSI C63.19-2019

RECEIPT DATE : 2024-03-07

TEST DATE : 2024-03-27

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Edited by:

Approved by:

Gan Yueming (Supervisor)

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Change History				
Version Date Reason for change				
1.0 2024-05-27		First edition		



1. Statement of RF Emission

The lowest RF audio interference level found during test as bellows:

Air Interface	Frequency Band	RF _{AIL} (dBm)
GSM CMRS Voice	GSM850	37.47
GSW CWRS VOICE	GSM1900	33.06

Note:

- This device is in compliance with compliance with RF_{AIL} requirements specified in FCC 47 CFR Part 20.19 and tested in accordance with the measurement methods and procedures specified in ANSI C63.19-2019 and FCC KDB publications.
- 2. When the test result is a critical value, we will use the measurement uncertainty give the judgment result based on the 95% confidence intervals.





2. Technical Information

Note: Provide by applicant.

2.1. Applicant and Manufacturer Information

Applicant:	Reliance Communications LLC
Applicant Address: 555 Wireless Blvd. Hauppauge, NY 11788, USA	
Manufacturer:	Unimaxcomm
Manufacturer Address:	35F,HBC HuiLong Center Building-II Minzhi Street,Longhua,
wianulacturer Address.	Shenzhen, P.R. China 518110

2.2. Equipment under Test (EUT) Description

Product Name:	Orbic Fun Pro 5G	
EUT IMEI:	354854560018907	
Hardware Version:	V1.0	
Software Version:	R678L5SLFP_V1.0.10_BLL	
Frequency Bands:	GSM 850: 824 MHz ~ 849 MHz	
	GSM 1900: 1850 MHz ~ 1910 MHz	
	WCDMA Band II: 1850 MHz ~ 1910 MHz	
	WCDMA Band IV: 1710 MHz ~ 1755 MHz	
	WCDMA Band V: 824 MHz ~ 849 MHz	
	LTE Band 2: 1850 MHz ~ 1910 MHz	
	LTE Band 4: 1710 MHz ~ 1755 MHz	
	LTE Band 5: 824 MHz ~ 849 MHz	
	LTE Band 7: 2500 MHz ~ 2570 MHz	
	LTE Band 12: 699 MHz ~ 716 MHz	
	LTE Band 13: 777 MHz ~ 787 MHz	
	LTE Band 14: 788 MHz ~ 798 MHz	
	LTE Band 17: 704 MHz ~ 716 MHz	
	LTE Band 25: 1850 MHz ~ 1915 MHz	
	LTE Band 26: 814 MHz ~ 849 MHz	
	LTE Band 30: 2305 MHz ~ 2315 MHz	
	LTE Band 41: 2496 MHz ~ 2690 MHz	
	LTE Band 48: 3550 MHz ~ 3700 MHz	
	LTE Band 66: 1710 MHz ~ 1780 MHz	
	LTE Band 71: 663 MHz ~ 698 MHz	
	5G NR n2: 1850 MHz ~ 1910 MHz	
	5G NR n5: 824 MHz ~ 849 MHz	





	5G NR n25: 185	0 MHz ~ 1915 MHz	
	5G NR n26: 814 MHz ~ 849 MHz		
	5G NR n41: 249	6 MHz ~ 2690 MHz	
	5G NR n48: 355	0 MHz ~ 3700 MHz	
	5G NR n66: 1710 MHz ~ 1780 MHz		
	5G NR n71: 663	MHz ~ 698 MHz	
	5G NR n77: 345	0 MHz ~ 3550 MHz; 3700 MHz ~3980 MHz	
	5G NR n78: 345	0 MHz ~ 3550 MHz; 3700 MHz ~ 3800 MHz	
	WLAN 2.4GHz:	2412 MHz ~ 2462 MHz	
	WLAN 5.2GHz:	5180 MHz ~ 5240 MHz	
	WLAN 5.8GHz:	5745 MHz ~ 5825 MHz	
	_	MHz ~ 2480 MHz	
	NFC: 13.56 MH	Z	
	WPT(RX): 110 k		
Modulation Mode:	GSM/GPRS: GN	MSK	
	EDGE: 8PSK		
	WCDMA: QPSK		
	LTE: QPSK, 16QAM, 64QAM, 256QAM (only CA support)		
	5G NR: DFT-s-OFDM/CP-OFDM, PI/2 BPSK		
	QPSK, 16QAM, 64QAM, 256QAM		
	802.11b: DSSS	00/11/2007	
	_	20/HT40/ac-VHT20/40/80: OFDM	
	BR+EDR: GFSK(1Mbps), π/4-DQPSK(2Mbps), 8-DPSK(3Mbps)		
	Bluetooth LE: GFSK(1Mbps) NFC: ASK		
Antonno tunos	WPT(RX): ASK WWAN: PIFA Ar	stanna	
Antenna type:	WLAN: PIFA An		
	Bluetooth: PIFA Antenna		
VoLTE Mode:	NFC: Loop Antenna		
VoWi-Fi Mode:	Support		
	Support		
SIM Cards Description:	SIM 1 GSM+WCDMA+LTE+5G NR		
	SIM 2 GSM+WCDMA +LTE+5G NR		
	For dual SIM card version, both the SIM 1 and SIM 2 are the same		
	chipset unit and tested as a single chipset, the SIM 1 was selected		
	for testing.		
Note:			

Note:

This report was updated based on the original report SZ23120302S03 (Model: R678L5SFP, FCC ID: 2ABGH-R678L5SFP) both of them are different from the model name, software version, FCC ID, enabling LTE B14/17/25/26/30/41/71 and NR n25/26/41/71, the others are



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the same as the original report. Therefore, RF emission needs to be retested and its latest testing results will be recorded in this report.

2. For more detailed description, please refer to specification or user manual supplied by the applicant and/or manufacturer.

2.3. Photographs of the EUT

Note: Please refer to the External Photos for the Photos of the EUT

2.4. Applied Reference Documents

Leading reference documents for testing:

		Method
Identity	Document Title	determination
		/Remark
FCC 47 CFR Part 20 (20.19)	Hearing aid-compatible mobile handsets	No deviation
	American National Standard Methods of	
ANSI C63.19-2019	Measurement of Compatibility between	No deviation
ANSI C63. 19-2019	Wireless Communications Devices and	No deviation
	Hearing Aids	
KDB 285076 D01v06r04	HAC Guidance	No deviation





3. Air Interface and Operating Mode

Air Interface	Band	Transport	Transport Simultaneous		Power
Air interrace	Dallu	Туре	Transmitter	Voice Service	Reduction
GSM	GSM850	VO	VALL AND DIT	CMDC Vaine	No
GSIVI	GSM1900] VO	WLAN, BT	CMRS Voice	No
WCDMA	Band II				No
(UMTS)	Band IV	VO	WLAN, BT	CMRS Voice	No
(010113)	Band V				No
	Band 2				No
	Band 4				No
	Band 5				No
	Band 7				No
	Band 12				No
	Band 13				No
FDD-LTE	Band 14			VoLTE	No
&	Band 17	VD	WLAN, BT		No
TDD-LTE	Band 25				No
	Band 26				No
	Band 30				No
	Band 41				No
	Band 48				No
	Band 66				No
	Band 71				No
	n2		WLAN, BT	N/A	No
	n5				No
	n25				No
	m26				No
EC ND	n41				No
5G NR	n48	DT			No
	n66				No
	n71				No
	n77	_			No
	n78				No
	2450	VD	GSM, UMTS, LTE, 5G NR	VoWiFi	No
\A/;/=;	5200				No
WiFi	(U-NII-1)				No
	5800				No



	(U-NII-3)				
ВТ	2450	DT	GSM, UMTS, LTE, 5G NR	N/A	No

Note:

- 1) Air Interface/Band MHz: List of all air interfaces and bands supported by the handset.
- 2) Type: For each air interface, indicate the type of voice transport mode:
 - VO = legacy Cellular Voice Service, from ANSI C63.19-2019;
 - ii. DT = Digital Transport only (no voice); and
 - VD = IP Voice Service over Digital Transport. iii.

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- 3) Simultaneous Transmitter: Indicate any air interface/bands that operate in simultaneous or concurrent service transmission mode.
- 4) Name of Voice Service: See Q4 in 285076 D03 HAC FAQ for further clarification.





4. WD Emission Requirements

According to ANSI C63.19-2019, the WD's conducted power must be at or below either the stated RF_{AIPL} (Table 4.1) or the stated peak power level (Table 4.2), or the average near-field emissions over the measurement area must be at or below the stated RF_{AIL} (Table 4.3), or the stated peak field strength (Table 4.4). The WD may demonstrate compliance by meeting any of these four requirements, but it must do so in each of its operating bands at its established worst-case normal speech-mode operating condition.

Table 4.1—Wireless device RF audio interference power level		
Frequency Range RF _{AIPL}		
(MHz)	(dBm)	
<960	29	
960–2000	26	
>2000	25	

Table 4.2—Wireless device RF peak power level			
Frequency Range RF _{Peak Power}			
(MHz)	(dBm)		
<960	35		
960–2000	32		
>2000	31		

Table 4.3—Wireless device RF audio interference level			
Frequency Range RF _{AIL}			
(MHz)	(dBm)		
<960	39		
960–2000	36		
>2000	35		

Table 4.4—Wireless device RF peak near-field level			
Frequency Range RF _{Peak}			
(MHz)	[dB(V/m)]		
<960	45		
960–2000	42		
>2000	41		

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5. HAC (RF) Measurement System

5.1.RF Measurement Setup

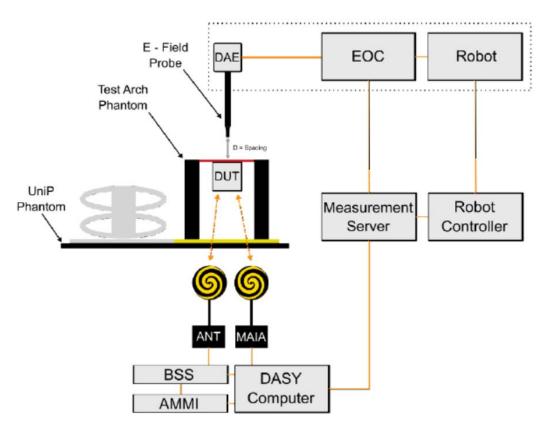


Fig 5.1 Typical DASY6/8 setup for HAC RF signal test



5.2. E-Field Probe

The RF measurement is conducted with the dosimetric probe (manufactured by SPEAG). The probe is specially designed and calibrated for use with high permittivity. The dosimetric probe has special calibration at different frequency. This probe has a built in optical surface detection system to prevent from collision with phantom.

E-Field Probe Specification <ER3DV6>

	One dipole parallel, two dipoles normal to		
Construction	probe axis		
	Built-in shielding against static charges		
Calibration	In air from 100 MHz to 3.0 GHz	and the second	
Calibration	(Absolute accuracy ±6.0%, k=2)	T .	
Frequency	10 MHz to 6 GHz;Linearity: ± 0.2 dB		
	± 0.2 dB in HSL (rotation around probe axis)		
Directivity	± 0.4 dB in HSL (rotation normal to probe		
	axis)		
	2 V/m to 1000 V/m	1 1	
Dynamic	(M3 or better device readings fall well below		
Range	diode	T T	
	compression point)	and the second	
Linearity	± 0.2 dB		
	Overall length: 330 mm (Tip: 16 mm)		
Dimensions	Tip diameter: 8 mm (Body: 12 mm)		
Dillicipions	Distance from probe tip to dipole centers: 2.5		
	mm	Fig 5.2 Photo of ER3DV6	

Probe Tip Description:

HAC field measurements take place in the close near field with high gradients. Increasing the measuring distance from the source will generally decrease the measured field values (in case

of the validation dipole approx. 10%per mm).

<Voltage to E-field Conversion>

The measured voltage is first linearized to a quantity proportional to the square of the E-field using the (a, b, c, d) set of parameters specific to the communication system and sensor:

$$V_{\text{compi}} = U_i + U_i^2 \cdot \frac{10^{\frac{d}{10}}}{dcp_i}$$





where V_{compi} = compensated voltage of channel i (μV)

(i = x,y,z)(i = x,y,z)

U_i = input voltage of channel i (μV)

(Probe parameter)

d = PMR factor d (dB)

(Probe parameter)

 d_{cpi} = diode compression point of channel i (μ V)

(Probe parameter, i = x,y,z)

$$V_{\text{compi}_{\text{dB}}\sqrt{\mu V}} = 10 \cdot \log_{10} (V_{\text{compi}})$$

$$\mathrm{corr}_i = a_i \cdot e^{-\left(\frac{V_{\mathrm{compi}_{\mathrm{dB}}\sqrt{\mu \nabla}} - b_i}{c_i}\right)^2}$$

where corr = correction factor of channel i (dB) (i = x,y,z)

 $V_{\text{compide}} \overline{\mu V}_{\text{compide}} = \text{compensated voltage of channel i } (dB \sqrt{\mu V})$ (i = x,y,z)

ai = PMR factor a of channel i (dB) (Probe parameter, i = x,y,z)

bi = PMR factor b of channel i (dB $\sqrt{\mu V}$) (Probe parameter, i = x,y,z)

ci = PMR factor c of channel i (Probe parameter, i = x,y,z).

The voltage $V_{idB\sqrt{\mu V}}$ is the linearized voltage in $dB\sqrt{\mu V}$

$$V_{idB\sqrt{\mu V}} = V_{compi_{dB}\sqrt{\mu V_{*}}}$$
 - corri

Where $V_{i_{dB}} \overline{\mu V}$ = linearized voltage of channel i (dB $\sqrt{\mu V}$) (i = x,y,z)

 $V_{\text{compi}_{dB} | \overline{\mu V_*}} = \text{compensated voltage of channel I } (dB \sqrt{\mu V})$ (i = x,y,z)

corri = correction factor of channel i (dB) (i = x,y,z)

Finally, the linearized voltage is converted in µV:

$$V_i = 10^{\frac{V_{i_{\text{dB}}\sqrt{\mu V}}}{10}}$$

The E-field data for each channel are calculated using the linearized voltage:

E-field probes:
$$E_i = \sqrt{\frac{V_i}{\text{Norm}_i \cdot \text{ConvF}}}$$

Where V_i = linearized voltage of channel i (i = x,y,z)

Norm_i = sensor sensitivity ($\mu V/(V/m)2$) of channel i (i = x,y,z)

ConvF = sensitivity enhancement in solution

E_i = electric field strength of channel i in V/m.

The RMS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{\text{tot}} = \sqrt{E_x^2 + E_y^2 + E_z^2}.$$





<Averaged E-field Calculation>

The averaged E-field is defined by

$$E_{avg} = \frac{1}{n} \cdot \sum_{i=1}^{n} E_i$$

where n =the number of measurement grid point

 E_i = the E-field measured at point i.

<RFail Calculation>

The RFail is finally computed with

RFail [dB(V=m)] =
$$20 \cdot \log_{10}(E_{avg}) + MIF$$

Where RFail = the Radio Frequency Audio Interference Level in dB(V/m)

E_{avg} = the averaged E-field in (V/m) calculated MIF = the Modulation Interference Factor in dB.

5.3. Data Acquisition Electronics (DAE)

The data acquisition electronics (DAE) consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. AD-converter and a command decoder and control logic unit. Transmission to the measurement server is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock.

The input impedance of the DAE is 200 MOhm; the inputs are symmetrical and floating. Common mode rejection is above 80 dB.



Fig 5.3 Photo of DAE

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6. RF Emission Measurement Procedure

6.1. Test Procedure: Direct Measurement—Alternative

The following methods are example step-by-step test procedures. Other comparable procedures may be used. Either manual or automatic test procedures may be used. The automated test procedure is preferred.

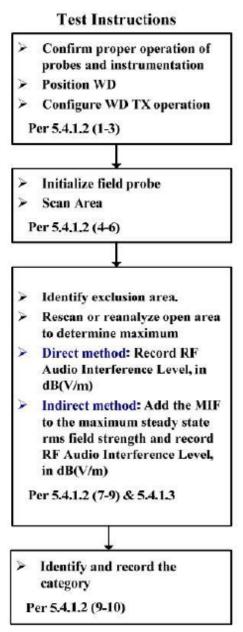
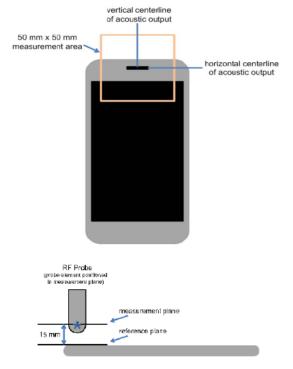


Fig 6.1 WD near-field emission scan flowchart



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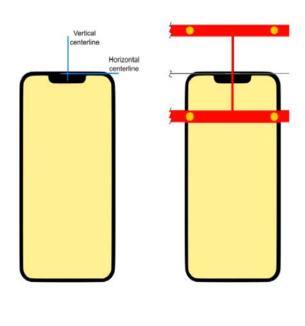


Fig 6.2 WD measurement and reference planes for RF emission measurements

Fig 6.3 Device Under Test Positioning under the Test

Arch

6.2. Test Procedure: Indirect Measurement—Preferred

- Confirm the proper operation of the field probe, probe measurement system, and other instrumentation and the positioning system.
- 2. Position the WD in its intended test position. A gauge block, depicted in A.1.2, can simplify this positioning.
- 3. Set the WD to transmit a fixed and repeatable combination of signal power and modulation characteristic that is representative of the worst case (highest interference potential) encountered in normal use. Transiently occurring start-up, changeover, or termination conditions, or other operations likely to occur less than 1% of the time during normal operation, may be excluded from consideration. Transiently occurring start-up, changeover, or termination conditions, or other operations likely to occur less than 1% of the time during normal operation, may be excluded from consideration.
- 4. The measurement area shall be centered on the acoustic output or the T-Coil mode measurement reference point, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm measurement area, which is contained in the measurement plane, described in 4.5.2 and illustrated in Figure A.1. If the field alignment method is used, align the probe for maximum field reception.





- 5. Record the reading at the output of the measurement system.
- 6. Scan the entire 50 mm by 50 mm measurement area in equally spaced step sizes and record the reading at each measurement point. The step size shall meet the specification for step size in 4.5.3.
- 7. Calculate the average of the measurements taken in Step 6.
- 8. Convert the average value found in Step g) to RF audio interference level, in volts per meter, by taking the square root of the reading and then dividing it by the measurement system transfer function, as established in 4.5.3.2.1 pre-test procedure. Convert the result to dB(V/m) by taking the base-10 logarithm and multiplying it by 20. Expressed as a formula:

RF audio interference level in db (V/m) = $20 \cdot \log (R_{ave}^{1/2}/TF)$

Where Rave is the average reading

9. Compare this RF audio interference level to the limits in 4.7 of ANSI C63.19-2019 and record the result.





7. Test Equipment List

Manufacturer	Name of Favinament	Turne/Medal	Serial	Calib	ration
Manufacturer	anufacturer Name of Equipment Type/Model		Number	Last Cal.	Due Date
SPEAG	DOSIMETRIC ASSESSMENT SYSTEM Software	cDASY6 HAC	V1.2	NCR	NCR
SPEAG	Isotropic E-Field Probe	ER3DV6	2434	2024.02.17	2025.02.16
SPEAG	Audio Holder	N/A	1094	NCR	NCR
SPEAG	835MHz Calibration Dipole	CD835V3	1113	2021.10.23	2024.10.22
SPEAG	1880MHz Calibration Dipole	CD1880V3	1111	2021.10.23	2024.10.22
SPEAG	Data Acquisition Electronics	DAE4	480	2023.09.19	2024.09.18
SPEAG	Test Arch Phantom	N/A	N/A	NCR	NCR
SPEAG	Phone Positioner	N/A	N/A	NCR	NCR
R&S	Power Senor	NRP8S	103215	2024.01.25	2025.01.24
Agilent	Power Meter	E4416A	MY45102093	2023.09.19	2024.09.18
R&S	Power Sensor	NRP8S	103240	2024.01.25	2025.01.24
Anritsu	Power Meter	E4418B	GB43318055	2023.06.21	2024.06.20
Agilent	Signal Generator	N5182B	MY53050509	2023.09.19	2024.09.18
R&S	Base Station	CMU200	107082	2023.06.21	2024.06.20
R&S	Base Station	CMW500	165755	2024.01.25	2025.01.24
PASTERNACK	Dual Directional Coupler	PE2214-10	N/A	NA	NA
Woken	Attenuator	WK0602-XX	N/A	NA	NA
Mini-Circuits	Power Amplifier	ZHL-42W+	608501717	NCR	NCR



8. System Validation

According to ANSI C63.19, before hearing aid testing commences, the experimental setup shall be validated. Sub clauses 6.3.1through 6.3.5 include a set of pretest procedures designed to validate the experimental setup to ensure the accuracy of the results. To verify that the hearing aid performs per the manufacturer's specifications, 6.3.5 advises that the hearing aid be pretested per ANSI S3.22.

8.1. Test setup

- In the simplified setup for system evaluation, the EUT is replaced by a calibrated dipole and the power source is replaced by a continuous wave which comes from a signal generator.
- 2. Position the E-field probe at a 15 mm distance from the top surface of the dipole, which is also fixed in an appropriate fixture.
- 3. Make sure that the desired measuring channel of the probe is aligned for maximum reception of the E-field generated by the dipole. This may be accomplished by rotating the probe until the maximum value is located. The E-field probe shall have been calibrated over the frequency range to be measured using standard calibration techniques.
- 4. Adjust the power level (20dBm→100mW) of the signal generator at the initial starting frequency such that the desired E-field strength at the 15 mm distance from the tip of the dipole is achieved. Setting the field strength to be in the range of category M2 is advised.
- 5. Step the frequency in increments of ≤1%, adjusting the power fed into the dipole such that the desired E-field strength is maintained.

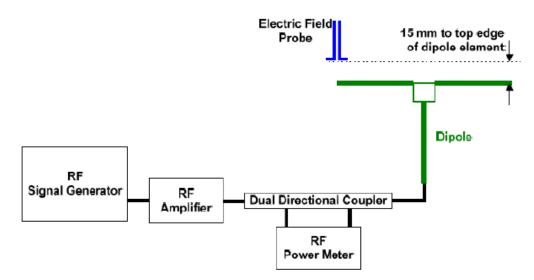


Fig 8.1 WD dipole calibration procedure





8.2. Validation Result

After testing, record the frequency and signal generator setting at each frequency for use during the actual immunity test. Comparing to the original E-field value provided by SPEAG, the verification data should be within its specification of 25 %. Table 6.1 shows the target value and measured value. The table below indicates the system performance check can meet the variation criterion and the plots can be referred to appendix A of this report. Deviation = ((Average E-field Value) - (Target value)) / (Target value) * 100%

Frequency (MHz)	Input Power (mW)	Target Value (V/m)	Emax (V/m)	Deviation (%)	Limit (%)	Date
835	100	110.8	107	-3.43	±12.8	2024.03.27
1880	100	89.5	98.5	10.06	±12.8	2024.03.27



9. Modulation Interference Factor

For any specific fixed and repeatable modulated signal, a Modulation Interference Factor (MIF, expressed in decibels) may be developed that relates its interference potential to its steady state rms signal level or average power level. This factor is a function only of the audio frequency amplitude modulation characteristics of the signal and is the same for field strength or conducted power measurements. It is important to emphasize that the MIF is valid only for a specific repeatable audio frequency amplitude modulation characteristic. Any change in modulation characteristic requires determination and application of a new MIF.

MIF may be determined using a radiated RF field, a conducted RF signal, or, in a preliminary stage, a mathematical analysis of a modeled RF signal.

- 1. Verify the slope accuracy and dynamic range capability over the desired operating frequency band of a fast probe or sensor, square-law detector, as specified in D.3, and weighting system as specified in D.4 and D.5. For the probe and instrumentation included in the measurement of MIF, additional calibration and application of calibration factors are not required.
- 2. Using RF illumination, or conducted coupling, apply the specific modulated signal in question to the measurement system at a level within its confirmed operating dynamic range.
- 3. Measure the steady-state rms level at the output of the fast probe or sensor.
- 4. Measure the steady-state average level at the weighting output.
- 5. Without changing the square-law detector or weighting system, and using RF illumination, or conducted coupling, substitute for the specific modulated signal a 1 kHz, 80% amplitude-modulated carrier at the same frequency and adjust its strength until the level at the weighting output equals the Step d) measurement.
- 6. Without changing the carrier level from Step e), remove the 1 kHz modulation and again measure the steady-state rms level indicated at the output of the fast probe or sensor.
- 7. The MIF for the specific modulation characteristic is given by the ratio of the Step 6 measurement to the Step 3 measurement, expressed in decibels (20*log(step 6/step 3).

In practice, Step 5 and Step 6 need not be repeated for each MIF determination if the relationship between the two measurements has been pre-established for the measurement system over the operating frequency and dynamic ranges. In such cases, only the modulation characteristic being tested needs to be available during WD testing.

MIF values applied in this test report were provided by the HAC equipment provider of SPEAG, and the worst values for all air interface are listed below to be determine the Low-power Exemption.





	1	
UID	Communication System Name	MIF(dB)
10021	GSM-FDD(TDMA,GMSK)	3.63
10025	EDGE-FDD (TDMA, 8PSK, TN 0)	3.75
10460	UMTS-FDD(WCDMA, AMR)	-25.43
10225	UMTS-FDD (HSPA+)	-20.39
10081	CDMA2000 (1xRTT, RC3 Full Rate)	-19.71
10295	CDMA2000 (1xRTT, RC1 SO3, 1/8th Rate 25 fr.)	3.26
10403	CDMA2000 (1xEV-DO)	-17.67
10169	LTE-FDD(SC-FDMA,1RB,20MHz,QPSK)	-15.63
10170	LTE-FDD(SC-FDMA,1RB,20MHz,16-QAM)	-9.76
10179	LTE-FDD(SC-FDMA,1RB,20MHz,64-QAM)	-9.93
10181	LTE-FDD(SC-FDMA,1RB,15MHz,QPSK)	-15.63
10175	LTE-FDD(SC-FDMA,1RB,10MHz,QPSK)	-15.63
10177	LTE-FDD(SC-FDMA,1RB,5MHz,QPSK)	-15.63
10184	LTE-FDD(SC-FDMA,1RB,3MHz,QPSK)	-15.62
10187	LTE-FDD(SC-FDMA,1RB,1.4MHz,QPSK)	-15.62
10172	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK)	-1.62
10173	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, 16-QAM)	-1.44
10174	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, 64-QAM)	-1.54
10240	LTE-TDD (SC-FDMA, 1 RB, 15 MHz, QPSK)	-1.62
10237	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, QPSK)	-1.62
10234	LTE-TDD (SC-FDMA, 1 RB, 5 MHz, QPSK)	-1.62
10231	LTE-TDD (SC-FDMA, 1 RB, 3 MHz, QPSK)	-1.62
10228	LTE-TDD (SC-FDMA, 1 RB, 1.4 MHz, QPSK)	-1.62
10061	IEEE 802.11b WiFi 2.4 GHz (DSSS, 11 Mbps)	-2.02
10077	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 54 Mbps)	0.12
10427	IEEE 802.11n (HT Greeneld, 150 Mbps, 64-QAM)	-13.44
10069	IEEE 802.11a/h WiFi 5 GHz (OFDM, 54 Mbps)	-3.15
10616	IEEE 802.11ac WiFi (40MHz, MCS0, 90pc duty cycle)	-5.57

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RF Audio Interference Power Level Evaluation

General Guidance

- 1. The maximum conducted power including tune-up limit of each air interface will be used to plusing the MIF and evaluating whether it complies with the RF_{AIPL} requirements defined in ANSI C63.19-2019 section 4.7 Table 4.1, or the RF Emission should be measured and the test results complies with RF audio interference level requirements of Table 4.3.
- 2. The EDGE mode is not required since it is less than the GSM Voice mode for the conducted power including tune-up limit.
- 3. When the results that the maximum conducted power each air interface plus MIF complies with the RF_{AIPL} requirements, means it complies with the WD emission requirements per ANSI C63.19-2019.
- 4. The maximum power of higher frequency bands of FDD-LTE and TDD-LTE will be used to determining the RFAIRL.
- 5. The maximum power including tune-up limit of each air interface was recorded in SAR report SZ24030059S01.

> RF_{AIPL} Evaluation

<WWAN>

Air Interface	Max Tune-up	Worst Case	Power +	Lowest RF _{AIPL}	C63.19 Test
Air interface	Limit (dBm)	MIF (dB)	MIF(dB)	(dBm)	Required
GSM 850	33.30	3.63	36.93	29	Yes
GSM 1900	32.00	3.63	35.63	26	Yes
UMTS	26.00	-25.43	0.57	26	No
FDD - LTE	25.80	-9.76	16.04	25	No
TDD - LTE	24.80	-1.62	23.18	25	No

<WWAN>

Air Interface	Max Tune-up Limit (dBm)	Worst Case MIF (dB)	Power + MIF(dB)	Lowest RF _{AIPL} (dBm)	C63.19 Test Required
802.11b	21.00	-2.02	18.98	25	No
802.11g	19.50	0.12	19.62	25	No
802.11n-HT20	19.50	-13.44	6.06	25	No
802.11n-HT40	20.00	-13.44	6.56	25	No
802.11a	20.00	-3.15	16.85	25	No
802.11n-HT20	19.50	-13.44	6.06	25	No
802.11n-HT40	20.00	-13.44	6.56	25	No
802.11ac-VHT20	19.50	-5.57	13.93	25	No



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802.11ac-VHT40	20.00	-5.57	14.43	25	No
802.11ac-VHT80	20.00	-5.57	14.43	25	No

11. Summary Test Results

General Guidance

This device was tested under the maximum volume, backlight off and mute on.

> RF_{AIL} Test Results

Plot No.	Air Interface	Mode	Channel	RF _{AIL} (dB V/m)	Verdict
	GSM850	GSM Voice	128	37.48	PASS
	GSM850	GSM Voice	189	37.83	PASS
	GSM850	GSM Voice	251	37.47	PASS
	GSM1900	GSM Voice	512	33.06	PASS
	GSM1900	GSM Voice	661	33.10	PASS
	GSM1900	GSM Voice	810	33.07	PASS



12. Uncertainty Assessment

The component of uncertainly may generally be categorized according to the methods used to evaluate them. The evaluation of uncertainly by the statistical analysis of a series of observations is termed a Type evaluation of uncertainty. The evaluation of uncertainty by means other than the statistical analysis of a series of observation is termed a Type B evaluation of uncertainty. Each component of uncertainty, however evaluated, is represented by an estimated standard deviation, termed standard uncertainty, which is determined by the positive square root of the estimated variance

The combined standard uncertainty of the measurement result represents the estimated standard deviation of the result. It is obtained by combining the individual standard uncertainties of both Type A and Type B evaluation using the usual "root-sum-squares" (RSS) methods of combining standard deviations by taking the positive square root of the estimated variances. Expanded uncertainty is a measure of uncertainty that defines an interval about the measurement result within which the measured value is confidently believed tolie. It is obtained by multiplying the combined standard uncertainty by a coverage factor. For purpose of this document, a coverage factor two is used, which corresponds to confidence interval of about 95 %.





	HAC Uncertainty Budget For ANSI C63.19-2019 600 - 6000 MHz, Scanning distance 15mm				
Error Description	Uncertainty Value (±%)	Probe Distance	Div.	(Ci) Eav	Standard Uncertainty (Eav) (±%)
Measurement System	•				
Probe Calibration	5.1	N	1	1	5.1
Axial Isotropy	4.7	R	1.732	1	2.7
Sensor Displacement	7.2	R	1.732	0.5	2.1
Boundary Effects	2.4	R	1.732	1	1.4
Phantom Boundary Effect	7.2	R	1.732	1	4.2
Probe Linearity	4.7	R	1.732	1	2.7
Scaling to Peak Power with MIF	10.0	R	1.732	1	5.8
System Detection Limit	1.0	R	1.732	1	0.6
Readout Electronics	0.3	N	1	1	0.3
Response Time	0.8	R	1.732	0	0
Integration Time	0.8	R	1.732	0	0
RF Ambient Conditions	2.6	R	1.732	1	1.7
RF Reflections	3.0	R	1.732	1	6.9
RF Reflections	12.2	R	1.732	1	6.9
Probe Positioner	1.2	R	1.732	1	0.7
Probe Positioning	3.0	R	1.732	1	1.7
Extrapolation and Interpolation	1.0	R	1.732	1	0.6
Test Sample Related		,			
Device Positioning Vertical	4.7	R	1.732	1	2.7
Device Positioning Lateral	1.0	R	1.732	1	0.6
Device Holder and Phantom	2.4	R	1.732	1	1.4
Power Drift	5.0	R	1.732	1	2.9
Phantom and Setup Related		,			
Phantom Thickness	2.4	R			
Combined Std. Uncertainty					13.2
Expanded Std. Uncertainty on F					26.4
Expanded Std. Uncertainty on F	ield				13.2





Annex A General Information

1. Identification of the Responsible Testing Laboratory

Laboratory Name:	Shenzhen Morlab Communications Technology Co., Ltd.		
Laboratory Address:	FL.1-3, Building A, FeiYang Science Park, No.8		
	LongChang Road, Block 67, BaoAn District, ShenZhen,		
	GuangDong Province, P. R. China		
Telephone:	+86 755 36698555		
Facsimile:	+86 755 36698525		

2. Identification of the Responsible Testing Location

Name:	Shenzhen Morlab Communications Technology Co., Ltd.
Address:	FL.1-3, Building A, FeiYang Science Park, No.8
	LongChang Road, Block 67, BaoAn District, ShenZhen,
	GuangDong Province, P. R. China

3. Facilities and Accreditations

The FCC designation number is CN1192, the test firm registration number is 226174.



The annex B will be submitted separately.

Annex C Plots of Performance System Check

The annex C will be submitted separately.

Annex D Plots of RF Emission

The annex D will be submitted separately.

Annex E DASY Calibration Certificate

The annex E will be submitted separately.

***** END OF MAIN REPORT *****

